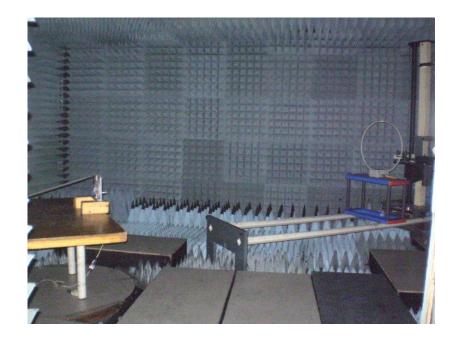


## Photograph No.1 Peak output power, occupied bandwidth, emission mask, conducted spurious emissions measurement setup





Photograph No.2 Spurious emissions measurement setup in the anechoic chamber below 30 MHz



Photograph No.3 Spurious emissions measurement setup in the anechoic chamber in 30 -1000 MHz

Photograph No.4 Spurious emissions measurement setup in the anechoic chamber above 1000 MHz



Photograph No.5 Spurious emissions measurement setup at the OATS above 1000 MHz



Photograph No.6 Setup for substitution method of spurious ERP measurements



## Photograph No.7 Frequency stability measurement setup